



Attorney's Docket No.: 05542-451001 / 5252/CMP

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Boguslaw Swedek et al. Art Unit : 3723
Serial No. : 09/847,867 Examiner : Alvin J. Grant
Filed : May 2, 2001
Title : INTEGRATED ENDPOINT DETECTION SYSTEM WITH OPTICAL AND EDDY CURRENT MONITORING

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Commissioner for Patents
P.O. Box 1450
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INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,



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Date: May 12, 2005

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CERTIFICATE OF MAILING BY FIRST CLASS MAIL

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Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 05542-451001	Application No. 09/847,867
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Boguslaw Swedek et al.		
		Filing Date May 2, 2001	Group Art Unit 3723	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	4,005,359	01/1977	Smoot			
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	AC	4,673,877	06/1987	Sakamoto et al.			
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	AAA	6,558,229	05/06/2003	Kimura et al.			
Examiner Signature				Date Considered			

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	ABB	6,563,308	05/2003	Nagano et al.			
	ACC	6,575,825	06/2003	Tolles et al.			
	ADD	6,586,337	07/2003	Parikh			
	AEE	6,621,264	09/2003	Lehman et al.			
	AFF	6,707,540	03/16/2004	Lehman et al.			

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
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	AII	3-295409	12/1991	Japan				
	AJJ	7-091948	04/1995	Japan				
	AKK	1-136009	05/1989	Japan				

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	ALL	
	AMM	
	ANN	
	AOO	

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